


<b>Search Notes</b> 	<b>Application/Control No.</b> 10670674	<b>Applicant(s)/Patent Under Reexamination</b> HARADA ET AL.
	<b>Examiner</b> Hung, Yubin	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	167,294	3/16/07	YH
347	116	3/16/07	YH
358	1.9,518-523	3/16/07	YH
399	301	3/16/07	YH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)	3/16/07	YH
ACM	2/16/07	YH
SPIE	2/16/07	YH
IEEE Xplore	2/16/07	YH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382	167,294	3/16/07	YH
347	116	3/16/07	YH
399	301	3/16/07	YH